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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Hideo ANDO, et al.FILING DATE  
February 19, 2002GROUP  
2615RECEIVED  
OCT 10 2002  
Technology Center 2600

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>HW</i>	AA	5,712,947	27Jan98	<u>Oguro, et al.</u>			
<i>HW</i>	AB	6,385,389 B1	07May02	<u>Maruyama, et al.</u>			
	AC						
	AD						
	AE						
	AF						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>HW</i>	AG	EP 1 065 665 A1	03Jan01	European Patent Office (in English)		
<i>HW</i>	AH	JP 5-165935	2Jul93	JAPAN	x	
<i>HW</i>	AI	JP 5-81787	02Apr93	JAPAN	x	
	AJ	JP 7-143429	02Jun95	JAPAN	x	
<i>HW</i>	AK	JP 8-106721	23Apr96	JAPAN	x	
<i>HW</i>	AL	JP 9-259539	03Oct97	JAPAN	x	
<i>HW</i>	AM	JP 11-215471	6Aug99	JAPAN (corresponding U.S. Patent no. 6,385,389 B1 Maruyama, et al.)		x
<i>HW</i>	AN	JP 11-238362	31Aug99	JAPAN (corresponding European Patent No. EP 1 065 665, ANDO, et al.)		x
	AO					
	AP					
	AQ					
	AR					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

<i>HW</i>	AS	<del>Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310033 (with English translation)</del>				
<i>HW</i>	AT	<del>Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310034 (with English translation)</del>				
<i>HW</i>	AU	<del>Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310035 (with English translation)</del>				
<i>HW</i>	AV	<del>Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310036 (with English translation)</del>				
<i>HW</i>	AW	<del>Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310037 (with English translation)</del>				
	AX					<input type="checkbox"/> Additional References sheet(s) attached

Examiner

*HUY NGUYEN*

Date Considered

*4/11/03*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.